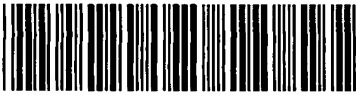


Search Notes

Application/Control No.

10/523,030

Examiner

Tran N. Nguyen

Applicant(s)/Patent under
Reexamination

MIYA ET AL

Art Unit

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SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
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